TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7MET373AFK

Octal D-Type Latch with 3-State Output

The TC7MET373AFK is an advanced high speed CMOS octal latch with 3-state output fabricated with silicon gate C^2MOS technology.

It achieves the high speed operation similar to equivalent bipolar schottky TTL while maintaining the CMOS low power dissipation.

This 8-bit D-type latch is controlled by a latch enable input (LE) and a output enable input (\overline{OE}).

When the $\overline{\text{OE}}$ input is high, the eight outputs are in a high impedance state.

The input voltage are compatible with TTL output voltage.

This device may be used as a level converter for interfacing 3.3 V to 5 V system.

Input protection and output circuit ensure that 0 to 5.5 V can

be applied to the input and output (*) pins without regard to the supply voltage. These structure prevents device destruction due to mismatched supply and input/output voltages such as battery back up, hot board insertion, etc.

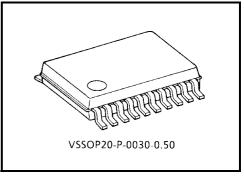
*: output in off-state

Features

- High speed: $t_{pd} = 7.7 \text{ ns} (typ.) (V_{CC} = 5 \text{ V})$
- Low power dissipation: $I_{CC} = 4 \mu A (max) (Ta = 25^{\circ}C)$
- Compatible with TTL outputs: VIL = 0.8 V (max)

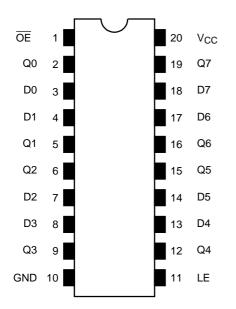
 $V_{IH} = 2.0 V (min)$

- Power down protection is provided on all inputs and outputs.
- Balanced propagation delays: $t_{pLH} \approx t_{pHL}$
- Low noise: VOLP = 1.5 V (max)
- Pin and function compatible with the 74 series (74AC/HC/F/ALS/LS etc.) 373 type.

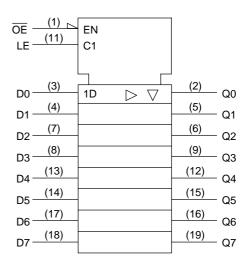


Weight: 0.03 g (typ.)

Pin Assignment (top view)



IEC Logic Symbol



Truth Table

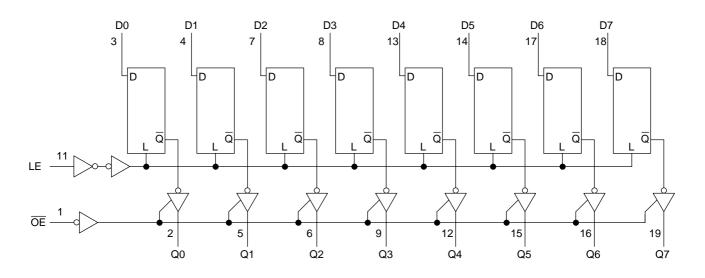
	Outputs		
ŌĒ	LE	D	Outputs
Н	Х	Х	Z
L	L	Х	Q _n
L	Н	L	L
L	Н	Н	Н

X: Don't care

Z: High impedance

 $\mathsf{Q}_n\!\!:\mathsf{Q}$ outputs are latched at the time when the LE input is taken to a low logic level.

System Diagram



Maximum Ratings

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	-0.5~7.0	V
DC input voltage	V _{IN}	-0.5~7.0	V
DC output voltage	Vour	-0.5~7.0 (Note1)	V
De output voltage	Vout	-0.5~V _{CC} + 0.5 (Note2)	v
Input diode current	I _{IK}	-20	mA
Output diode current	I _{OK}	±20 (Note3)	mA
DC output current	IOUT	±25	mA
DC V _{CC} /ground current	ICC	±75	mA
Power dissipation	PD	180	mW
Storage temperature	T _{stg}	-65~150	°C

Note1: Output in off-state

Note2: High or low state. $I_{\mbox{OUT}}$ absolute maximum rating must be observed.

Note3: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	4.5~5.5	V
Input voltage	V _{IN}	0~5.5	V
Output voltage	V _{OUT}	0~5.5 (Note4)	V
Output voltage		0~V _{CC} (Note5)	v
Operating temperature	T _{opr}	-40~85	°C
Input rise and fall time	dt/dv	0~20	ns/V

Note4: Output in off-state

Note5: High or low state

Electrical Characteristics

DC Characteristics

Characteristics		Symbol	Teet	Test Condition		Ta = 25°C			Ta = -40~85°C		Unit
Charact	ensues	Symbol	Test	Condition	$V_{CC}(V)$	Min	Typ. Max Min I		Max	Onic	
Input voltage	High level	VIH		_	4.5~5.5	2.0			2.0		V
mput voltage	Low level	VIL		_	4.5~5.5	_	_	0.8	_	0.8	v
	High level	Vou	$V_{IN} = V_{IH}$	I _{OH} = -50 μA	4.5	4.4	4.5		4.4	_	V
Output voltage	i ligit level	Vон	or V _{IL}	I _{OH} = -8 mA	4.5	3.94	_	_	3.80	_	
	High level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	$I_{OL} = 50 \ \mu A$	4.5	_	0	0.1	_	0.1	
				I _{OL} = 8 mA	4.5	_	_	0.36	_	0.44	
3-state output o	ff-state current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or } GND$		5.5		_	±0.25	_	±2.50	μΑ
Input leakage cu	urrent	I _{IN}	V _{IN} = 5.5 V	V or GND	0~5.5	_		±0.1	_	±1.0	μA
Quiescent supply current		ICC	$V_{IN} = V_{CC}$ or GND		5.5	_	_	4.0	_	40.0	μA
		Ісст	Per input: V _{IN} = 3.4 V Other input: V _{CC} or GND		5.5	_	_	1.35	_	1.50	mA
Output leakage	current	I _{OPD}	V _{OUT} = 5.5 V		0	_	_	0.5		5.0	μA

Timing Requirements (Input: $t_r = t_f = 3 \text{ ns}$)

Characteristics Sy	Symbol	Test Condition		Ta = 25°C		Ta = -40~85°C	Unit
	Symbol	Test Condition	V _{CC} (V)	Тур.	Limit	Limit	Unit
Minimum pulse width (LE)	t _{w (H)} t _{w (L)}	—	5.0 ± 0.5	_	6.5	8.5	ns
Minimum set-up time	ts	—	5.0 ± 0.5	_	1.5	1.5	ns
Minimum hold time	t _h	—	5.0 ± 0.5	_	3.5	3.5	ns

AC Electrical Characteristics (Input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = -4	Unit	
	Symbol	Test Condition	V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Min	Max	Unit
Propagation delay time	t _{pLH}		5.0 ± 0.5	15	_	7.7	12.3	1.0	13.5	ns
(LE-Q)	t _{pHL}		5.0 ± 0.5	50	_	8.5	13.3	1.0	14.5	115
Propagation delay time	t _{pLH}		5.0 ± 0.5	15	_	5.1	8.5	1.0	9.5	ns
(D-Q)	tpHL		5.0 ± 0.5	50	_	5.9	9.5	1.0	10.5	
	t _{pZL} t _{pZH}	$R_L = 1 k\Omega$	5.0 ± 0.5	15	_	6.3	10.9	1.0	12.5	ns
				50	_	7.1	11.9	1.0	13.5	
3-state output disable time	t _{pLZ} t _{pHZ}	$R_L = 1 \ k\Omega$	5.0 ± 0.5	50		8.8	11.2	1.0	12.0	ns
Output to output skew	t _{osLH} t _{osHL}	(Note6)	5.0 ± 0.5	50		_	1.0	_	1.0	ns
Input capacitance	C _{IN}	_		_	4	10	_	10	pF	
Output capacitance	C _{OUT}	_			9		_		pF	
Power dissipation capacitance	C _{PD}			(Note7)		25	_	_		pF

Note6: Parameter guaranteed by design.

 $t_{OSLH} = |t_{pLHm} - t_{pLHn}|, \ t_{OSHL} = |t_{pHLm} - t_{pHLn}|$

Note7: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8$ (per latch)

And the total $C_{\mbox{PD}}$ when n pcs. of latch operate can be gained by the following equation:

 C_{PD} (total) = 14 + 11 · n

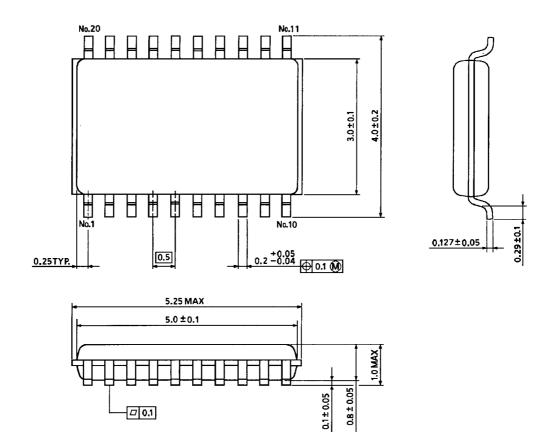
Noise Characteristics (Input: t_r = t_f = 3 ns)

Characteristics	Symbol	Test Condition	_	Ta = 25°C		Unit
Characteristics	Symbol	Test Condition	$V_{CC}(V)$	Тур.	Limit	Unit
Quiet output maximum dynamic V _{OL}	V _{OLP}	$C_L = 50 \text{ pF}$	5.0	1.1	1.5	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	$C_L = 50 \text{ pF}$	5.0	-1.1	-1.5	V
Minimum high level dynamic input voltage V_{IH}	VIHD	$C_L = 50 \text{ pF}$	5.0	_	2.0	V
Maximum low level dynamic input voltage V_{IL}	V _{ILD}	C _L = 50 pF	5.0	_	0.8	V

Package Dimensions

VSSOP20-P-0030-0.50

Unit : mm



Weight: 0.03 g (typ.)

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